

## P-Channel Enhancement Mode Field Effect Transistor

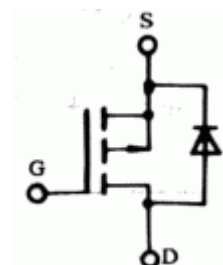
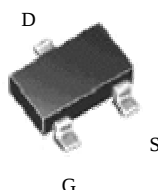
### FEATURES

- Super high dense cell design for low  $R_{DS(ON)}$
- Rugged and reliable
- Simple drive requirement
- SOT-23 package

| PRODUCT SUMMARY |       |                                |
|-----------------|-------|--------------------------------|
| $V_{DSS}$       | $I_D$ | $R_{DS(ON)}$ (m $\Omega$ ) Typ |
| -20V            | -3.6A | 95@ $V_{GS}=-4.5V$             |
|                 |       | 115 @ $V_{GS}=-2.5V$           |



NOTE: The Si2303 is available in a lead-free package



### ABSOLUTE MAXIMUM RATINGS ( $T_A=25^{\circ}C$ unless otherwise noted)

| Parameter                                                  | Symbol         | Limit      | Unit        |
|------------------------------------------------------------|----------------|------------|-------------|
| Drain-Source Voltage                                       | $V_{DS}$       | -20        | V           |
| Gate-Source Voltage                                        | $V_{GS}$       | $\pm 12$   | V           |
| Drain Current-Continuous <sup>a</sup> @ $T_j=125^{\circ}C$ | $I_D$          | -3.6       | A           |
| - Pulse $d^b$                                              | $I_{DM}$       | -11        | A           |
| Drain-source Diode Forward Current <sup>a</sup>            | $I_S$          | -1.25      | A           |
| Maximum Power Dissipation <sup>a</sup>                     | $P_D$          | 1.25       | W           |
| Operating Junction and Storage Temperature Range           | $T_j, T_{STG}$ | -55 to 150 | $^{\circ}C$ |

### THERMAL CHARACTERISTICS

|                                                      |             |     |               |
|------------------------------------------------------|-------------|-----|---------------|
| Thermal Resistance, Junction-to Ambient <sup>a</sup> | $R_{th JA}$ | 100 | $^{\circ}C/W$ |
|------------------------------------------------------|-------------|-----|---------------|

# Si2303

## ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

| Parameter                        | Symbol               | Condition                                                                                                                     | Min  | Typ  | Max  | Unit |
|----------------------------------|----------------------|-------------------------------------------------------------------------------------------------------------------------------|------|------|------|------|
| OFF CHARACTERISTICS              |                      |                                                                                                                               |      |      |      |      |
| Drain-Source Breakdown Voltage   | BV <sub>DSS</sub>    | V <sub>GS</sub> =0V,I <sub>D</sub> =-250μA                                                                                    | -20  |      |      | V    |
| Zero Gate Voltage Drain Current  | I <sub>DSS</sub>     | V <sub>DS</sub> =-16V,V <sub>GS</sub> =0V                                                                                     |      |      | 1    | μA   |
| Gate-Body Leakage                | I <sub>GSS</sub>     | V <sub>GS</sub> =±10V,V <sub>Ds</sub> =0V                                                                                     |      |      | ±100 | nA   |
| ON CHARACTERITICS                |                      |                                                                                                                               |      |      |      |      |
| Gate Threshold Voltage           | V <sub>GS</sub> (th) | V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250μA                                                                      | -0.5 | -0.8 | -1.5 | V    |
| Drain-Source On-State Resistance | R <sub>Ds</sub> (ON) | V <sub>GS</sub> =-4.5V,I <sub>D</sub> =-2.8A                                                                                  |      | 95   | 110  | m Ω  |
|                                  |                      | V <sub>GS</sub> =-2.5V,I <sub>D</sub> =-2.0A                                                                                  |      | 115  | 145  |      |
| Forward Transconductance         | g <sub>FS</sub>      | V <sub>GS</sub> =-5V,I <sub>D</sub> =-5A                                                                                      |      | 5    |      | S    |
| DAYNAMIC CHARACTERISTICS         |                      |                                                                                                                               |      |      |      |      |
| Input Capacitance                | C <sub>ISS</sub>     | V <sub>Ds</sub> =-10V,V <sub>GS</sub> =0V<br>f=1.0MHz                                                                         |      | 586  |      | pF   |
| Output Capacitance               | C <sub>OSS</sub>     |                                                                                                                               |      | 101  |      | pF   |
| Reverse Transfer Capacitance     | C <sub>RSS</sub>     |                                                                                                                               |      | 59   |      | pF   |
| SWITCHING CHARACTERISISTICS      |                      |                                                                                                                               |      |      |      |      |
| Turn-On Delay Time               | t <sub>D</sub> (ON)  | V <sub>DD</sub> =-10V<br>I <sub>D</sub> =-2.8A,<br>V <sub>GEN</sub> =-4.5V<br>R <sub>L</sub> =10ohm<br>R <sub>GEN</sub> =6ohm |      | 6.5  |      | ns   |
| Rise Time                        | t <sub>r</sub>       |                                                                                                                               |      | 32.1 |      | ns   |
| Turn-Off Delay Time              | t <sub>D</sub> (OFF) |                                                                                                                               |      | 58.4 |      | ns   |
| Fall Time                        | t <sub>f</sub>       |                                                                                                                               |      | 48   |      | ns   |
| Total Gate Charge                | Q <sub>g</sub>       | V <sub>Ds</sub> =-10V,I <sub>D</sub> =-3A<br>V <sub>GS</sub> =-4.5V                                                           |      | 6    |      | nC   |
| Gate-Source Charge               | Q <sub>gs</sub>      |                                                                                                                               |      | 1.35 |      | nC   |
| Gate-Drain Charge                | Q <sub>gd</sub>      |                                                                                                                               |      | 1.5  |      | nC   |

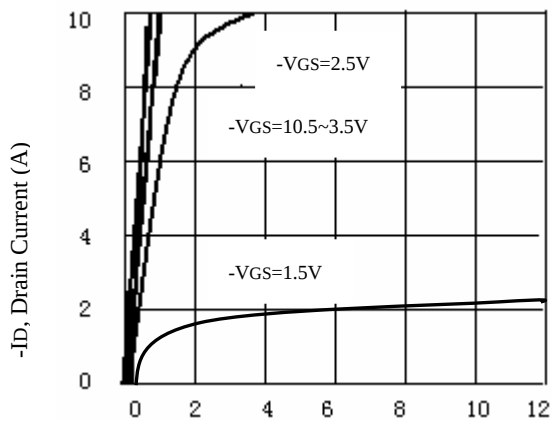
# Si2303

## ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

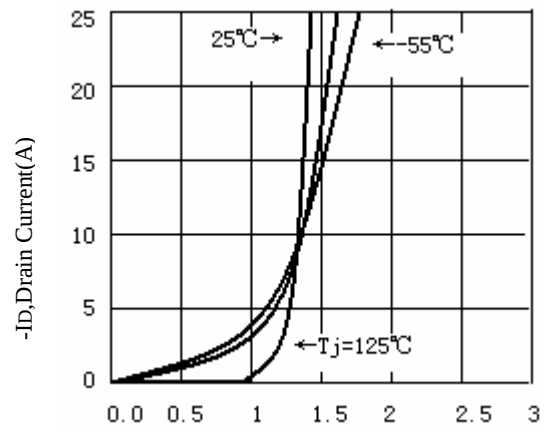
| Parameter                          | Symbol          | Condition                                   | Min | Typ   | Max  | Unit |
|------------------------------------|-----------------|---------------------------------------------|-----|-------|------|------|
| DRAIN-SOURCE DIODE CHARACTERISTICS |                 |                                             |     |       |      |      |
| Diode Forward Voltage              | V <sub>SD</sub> | V <sub>GS</sub> =0V, I <sub>S</sub> =-1.25A |     | -0.81 | -1.2 | V    |

### Notes

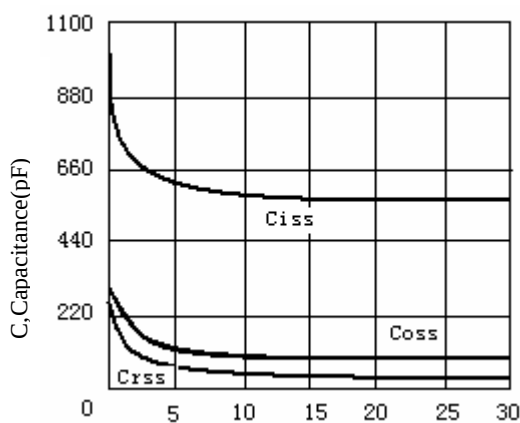
- Surface Mounted on FR4 Board,  $t \leq 10\text{sec}$
- Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty  $\leq 2\%$
- Guaranteed by design, not subject to production testing.



- V<sub>ds</sub>, Drain-to-Source Voltage (V)  
Figure 1. Output Characteristics



- V<sub>GS</sub>, Gate-to-source Voltage (V)  
Figure 2. Transfer Characteristics



- V<sub>GS</sub>, Drain-to Source Voltage  
Figure 3. Capacitance

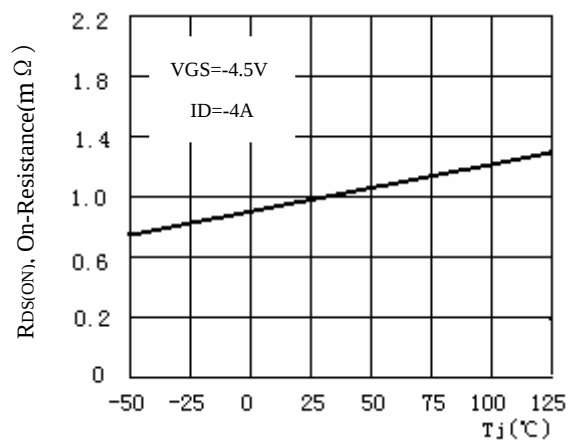


Figure 4. On-Resistance Variation with Temperature

# Si2303

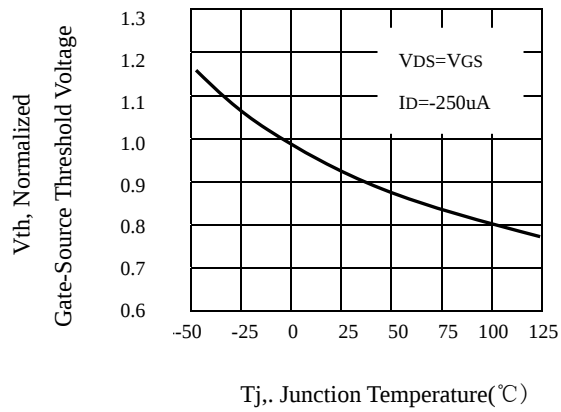


Figure 5. Gate Threshold Variation With Temperature

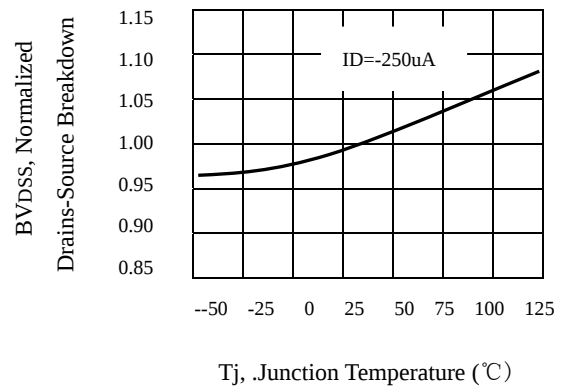


Figure 6. Breakdown Voltage Variation With Temperature

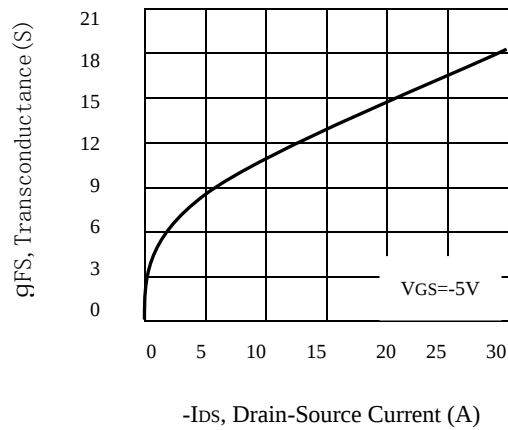


Figure 7. Transconductance Variation With Drain Current

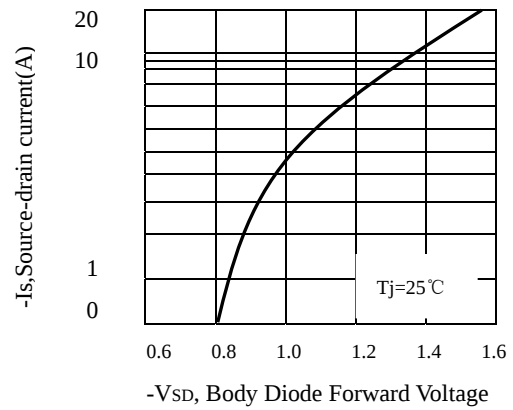


Figure 8. Body Diode Forward Voltage Variation with Source Current

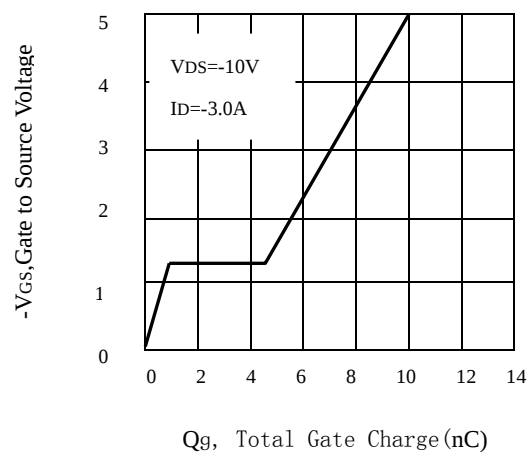


Figure 9. Gate Charge

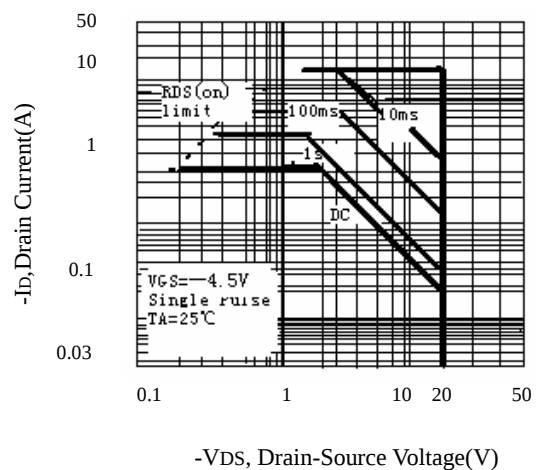


Figure 10. Maximum Safe Operating Area